

Notice of References Cited

Application/Control No.

10/055,301

Applicant(s)/Patent Under
Reexamination
SHEEK ET AL.

Examiner

John J. Zimmerman

Art Unit

1775

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,403,014	09-1983	Bergmann, Erich	428/546
	B	US-4,680,438	07-1987	Witting et al.	200/268
	C	US-5,037,517	08-1991	Randhawa, Harbhajan S.	204/192.15
	D	US-5,426,000	06-1995	Labib et al.	428/547
	E	US-6,245,435	06-2001	O'Brien et al.	428/472
	F	US-6,454,861 B1	09-2002	Chaleix et al.	118/718
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2126256	03-1984	UK	Sawada et al.	---
	O	63-129102	06-1988	Japan	Hiroaki et al.	---
	P	06-017230	01-1994	Japan	Masao	---
	Q	06-073530	03-1994	Japan	Katsuhiko et al.	---
	R	2284431	06-1995	UK	Wang	---
	S	2314604	01-1998	UK	Fukutome et al.	---
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.